

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

High Bay Lighting Control System

Dialight Corp.

1501 Route 34 south

Farmingdale, New Jersey, NJ 07727

United States of America

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1501 Route 34 south

Farmingdale, New Jersey, NJ 07727

United States of America

Additional information on page 2

SANMINA SCI SYSTEMS DE MEXICO S.A. DE C.V.

Carretera Guadalajara-Chapala Km 15.5 No. 29

45640, Tlajomulco de Zuñiga, Jalisco

Mexico

100-277 V~; 50/60 Hz; 600 mA

ta: -40 °C to +65 °C

Dialight

GAUW24AG

Additional information on page 2

IEC 60669-1:1998, IEC 60669-1:1998/AMD1:1999, IEC 60669-1:1998/AMD2:2006, IEC 60669-2-1:2002, IEC 60669-2-1:2002/AMD1:2008, IEC 60669-2-1:2002/AMD2:2015

National differences:

AU. NZ

2218101.50A and 2218101.50B

This CB Test Certificate is issued by the National Certification Body

DEKRA Certification B.V. Meander 1051, NL-6825 MJ Arnhem, Netherlands

Date: 2018-03-13



Signature: H.L. Schendstok

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